

## 2A 600V N-channel Enhancement Mode Power MOSFET

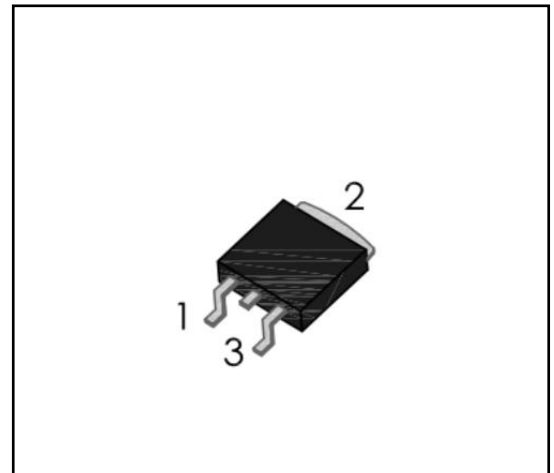
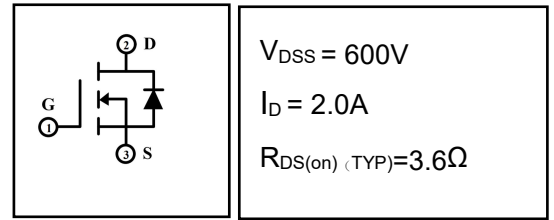
### 1 Description

These N-channel enhanced vdmofets, is obtained by the self-aligned planar technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. Which accords with the RoHS standard.

- Fast switching
- ESD improved capability
- Low on resistance( $R_{dson} \leq 4.5\Omega$ )
- Low gate charge(Typ: 9.5nC)
- Low reverse transfer capacitances(Typ: 3pF)
- 100% single pulse avalanche energy test
- 100%  $\Delta V_{DS}$  test

### 3 Applications

- Used in various power switching circuit for system miniaturization and higher efficiency.
- Power switch circuit of electron ballast and adaptor.



## 4 Electrical Characteristics

### 4.1 Absolute Maximum Ratings (Tc=25°C, unless otherwise noted)

| PARAMETER  | SYMBOL             | VALUE     | UNIT |
|--|--------------------|-----------|------|
| Drain-Source Voltage                                   | $V_{DS}$           | 600       | V    |
| Gate-Source Voltage                                    | $V_{GS}$           | $\pm 30$  | V    |
| Drain Current(continuous) <sup>(Note 3)</sup>          | $I_D$              | 2         | A    |
| Drain Current(continuous)(T=100°C) <sup>(Note 3)</sup> | $I_D$              | 1.3       | A    |
| Drain Current(Pulsed)                                  | $I_{DM}$           | 8         | A    |
| Single Pulse Avalanche Energy <sup>(Note 4)</sup>      | $E_{AS}$           | 60        | mJ   |
| Derating Factor above                                  | $T_a = 25^\circ C$ | 0.28      | W    |
| Power Dissipation                                      | $T_c = 25^\circ C$ |           |      |
| Operating Junction Temperature Range                   | $T_j$              | -55 ~ 150 | °C   |
| Storage Temperature Range                              | $T_{stg}$          | -55 ~ 150 | °C   |

### 4.2 Thermal Characteristics

| PARAMETER                                 | SYMBOL     | VALUE | UNIT |
|---|------------|-------|------|
| Thermal Resistance, Junction to Case-sink | $R_{thJC}$ | 3.57  | °C/W |
| Thermal Resistance, Junction to Ambient   | $R_{thJA}$ | 100   | °C/W |

**4.3 Electrical Characteristics** (Tc=25°C, unless otherwise noted)

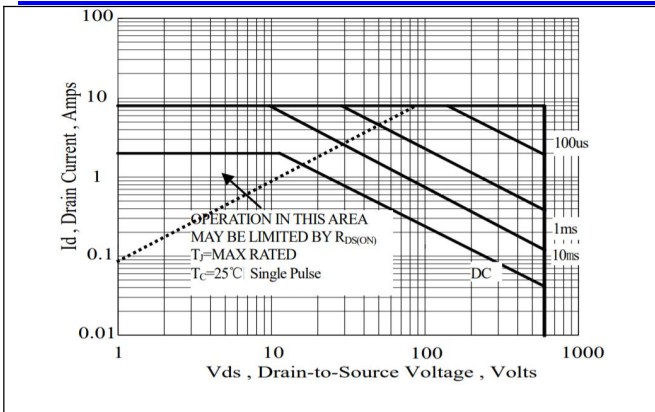
| PARAMETER                                      | SYMBOL              | Test Condition  | VALUE |     |      | UNIT |
|--|---------------------|---|-------|-----|------|------|
|  |                     |   | MIN   | TYP | MAX  |      |
| <b>Off Characteristics</b>                     |                     |   |       |     |      |      |
| Drain-source Breakdown Voltage                 | BV <sub>DSS</sub>   | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 600   | --  | --   | V    |
| Zero Gate Voltage Drain Current                | I <sub>DSS</sub>    | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V,<br>T <sub>C</sub> =25°C                           | --    | --  | 1    | μA   |
|  |                     | V <sub>DS</sub> =480V, V <sub>GS</sub> =0V,<br>T <sub>C</sub> =125°C                          | --    | --  | 100  | μA   |
| Gate-to-Body Leakage Current                   | I <sub>GSS</sub>    | V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V  | --    | --  | ±100 | nA   |
| <b>On Characteristics</b> (Note 3)             |                     |   |       |     |      |      |
| Gate threshold voltage                         | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                      | 2.0   | --  | 4.0  | V    |
| Drain-source on Resistance                     | R <sub>DS(on)</sub> | V <sub>GS</sub> =10V, I <sub>D</sub> =1.0A  | --    | 3.6 | 4.5  | Ω    |
| <b>Dynamic Characteristics</b>                 |                     |   |       |     |      |      |
| Input Capacitance                              | C <sub>iss</sub>    | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V,<br>f=1.0MHz  | --    | 335 | --   | pF   |
| Output Capacitance                             | C <sub>oss</sub>    |   | --    | 33  | --   |      |
| Reverse Transfer Capacitance                   | C <sub>rss</sub>    |   | --    | 3   | --   |      |
| Turn-on Delay Time                             | T <sub>d(on)</sub>  | I <sub>D</sub> =2A, V <sub>DD</sub> =300V,<br>V <sub>GS</sub> =10V, R <sub>G</sub> =10Ω       | --    | 11  | --   | ns   |
| Turn-on Rise Time                              | t <sub>r</sub>      |   | --    | 13  | --   |      |
| Turn-off Delay Time                            | T <sub>d(off)</sub> |   | --    | 29  | --   |      |
| Turn-off Fall                                  | t <sub>f</sub>      |   | --    | 12  | --   |      |
| Total Gate Charge                              | Q <sub>g</sub>      | I <sub>D</sub> =2A, V <sub>DD</sub> =480V,<br>V <sub>GS</sub> =10V                            | --    | 9.5 | --   | nC   |
| Gate-to-Source Charge                          | Q <sub>gs</sub>     |   | --    | 1.5 | --   |      |
| Gate-to-Drain("Miller")C harge                 | Q <sub>gd</sub>     |   | --    | 4.9 | --   |      |
| <b>Drain-Source Diode Characteristics</b>      |                     |   |       |     |      |      |
| Diode Forward Voltage (Note 3)                 | V <sub>FSD</sub>    | V <sub>GS</sub> =0V, I <sub>S</sub> =2A   | --    | --  | 1.5  | V    |
| Continuous Source Current (BodyDiode) (Note 3) | I <sub>S</sub>      |   | --    | --  | 2    | A    |
| Reverse Recovery Time                          | t <sub>rr</sub>     | T <sub>J</sub> =25°C, I <sub>F</sub> =2A,<br>dI <sub>F</sub> /dt=100A/μS, V <sub>GS</sub> =0V | --    | 187 | --   | ns   |
| Reverse Recovery Charge                        | Q <sub>rr</sub>     |   | --    | 610 | --   | nC   |

Notes:

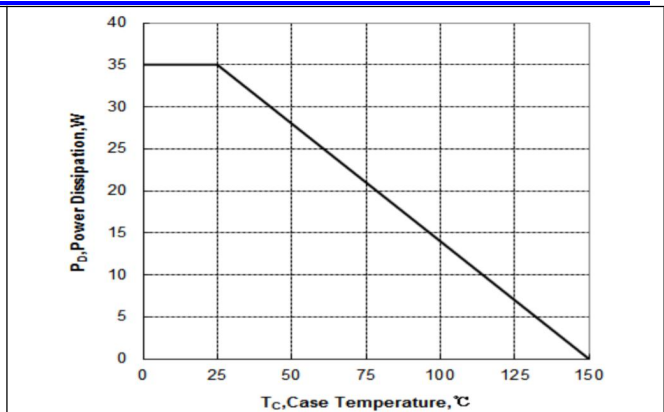
- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width ≤ 300μs, duty cycle ≤ 2%.
- 4: L=10mH, I<sub>D</sub>=3.5A, V<sub>DD</sub>=50V, Start T<sub>J</sub>=25°C.

**5 Typical Test Circuit and Waveform**

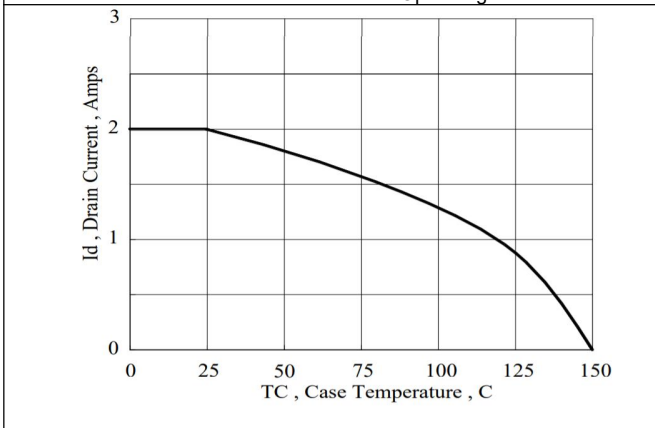
|   |  |
|---|--|
|   |  |
| <p style="text-align: center;">Gate Charge Test Circuit</p>                   | <p style="text-align: center;">Gate Charge Waveforms</p>   |
| <p style="text-align: center;">Resistive Switching Test Circuit</p>           | <p style="text-align: center;">Resistive Switching Waveforms</p>                                   |
| <p style="text-align: center;">Diode Reverse Recovery Test Circuit</p>        | <p style="text-align: center;">Diode Reverse Recovery Waveform</p> $E_{AS} = \frac{I_{AS}^2 L}{2}$ |
| <p style="text-align: center;">Unclamped Inductive Switching Test Circuit</p> | <p style="text-align: center;">Unclamped Inductive Switching Waveform</p>                          |



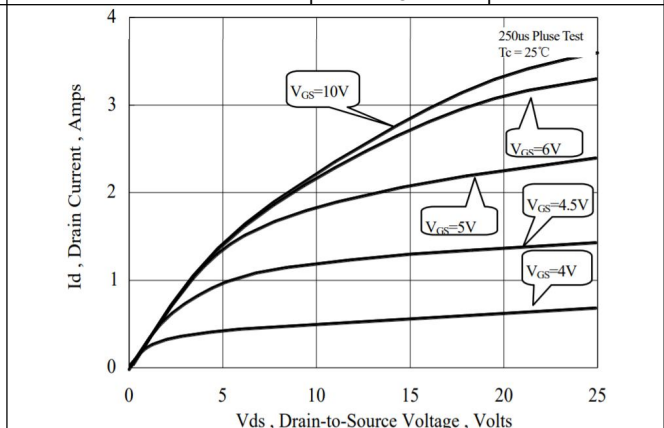
Maximum Forward Bias Safe Operating Area



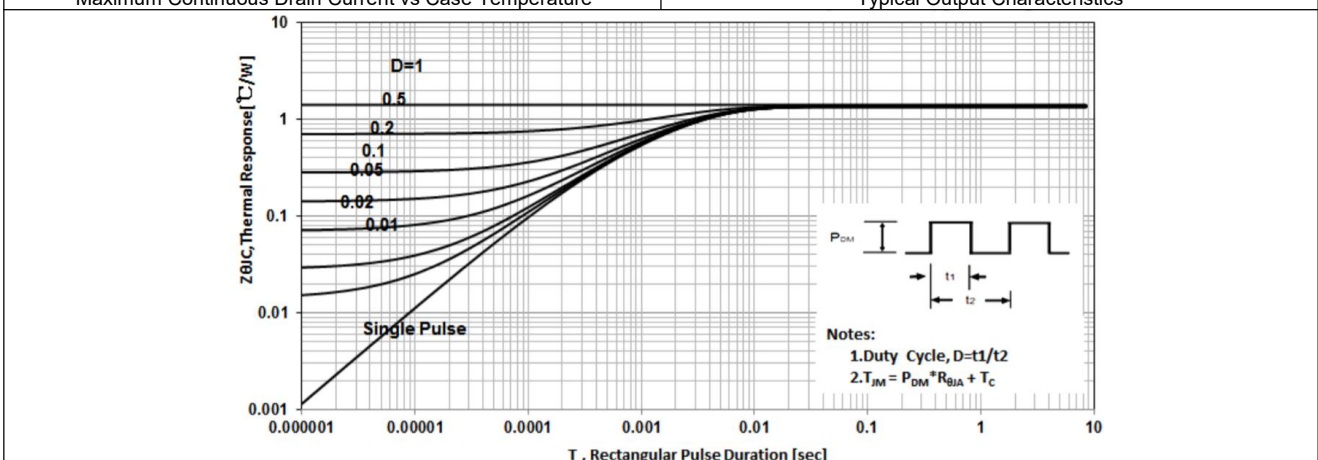
Maximum Power Dissipation vs Case Temperature



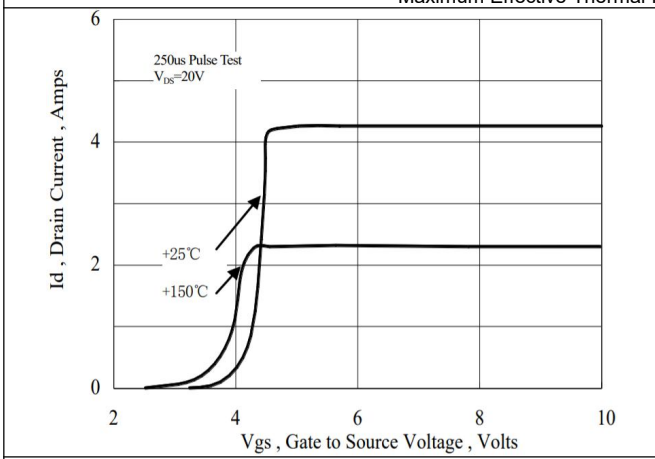
Maximum Continuous Drain Current vs Case Temperature



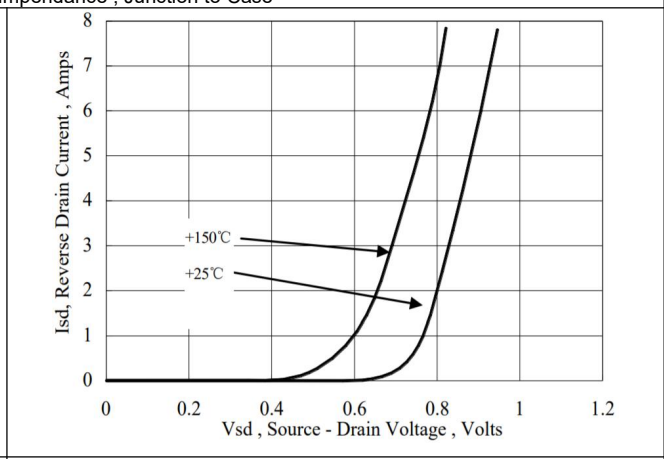
Typical Output Characteristics



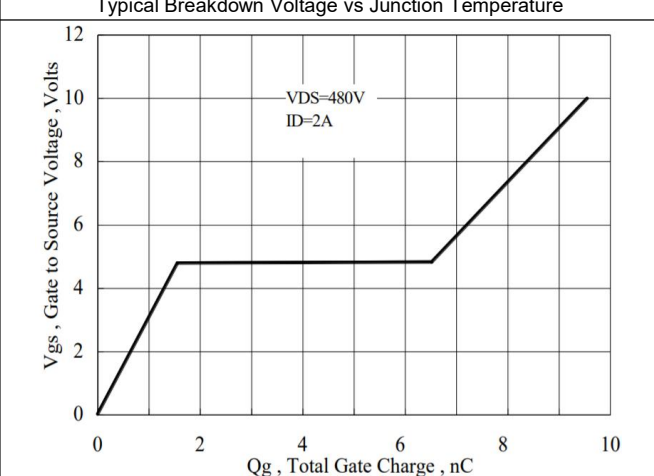
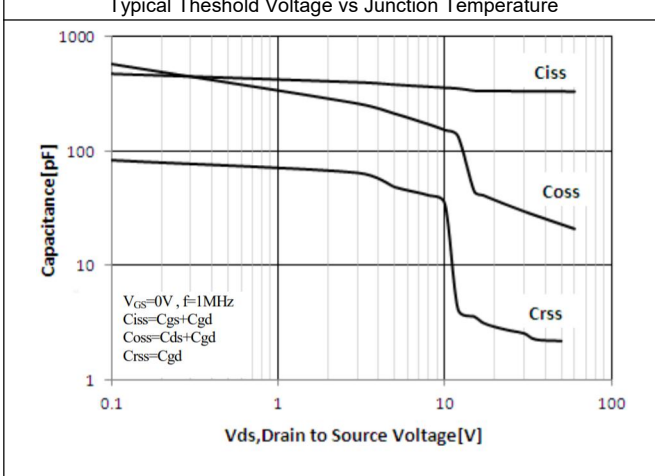
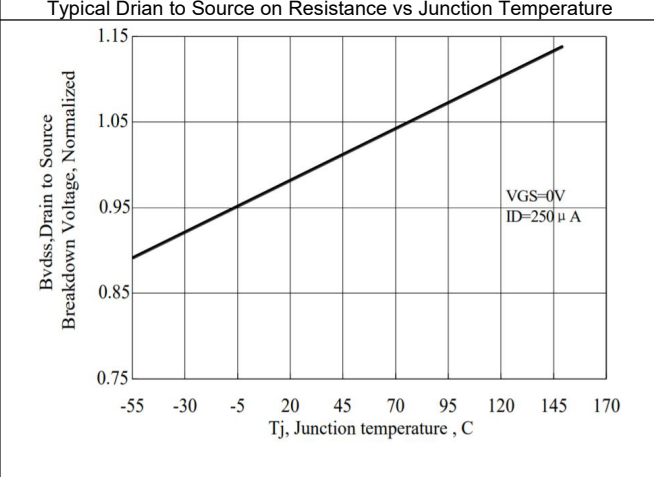
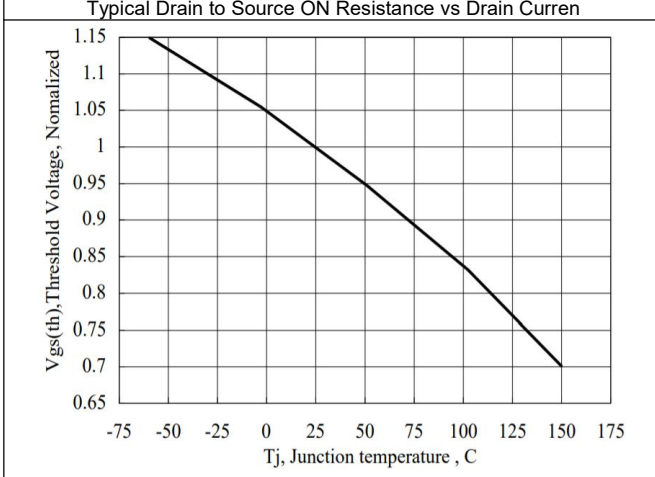
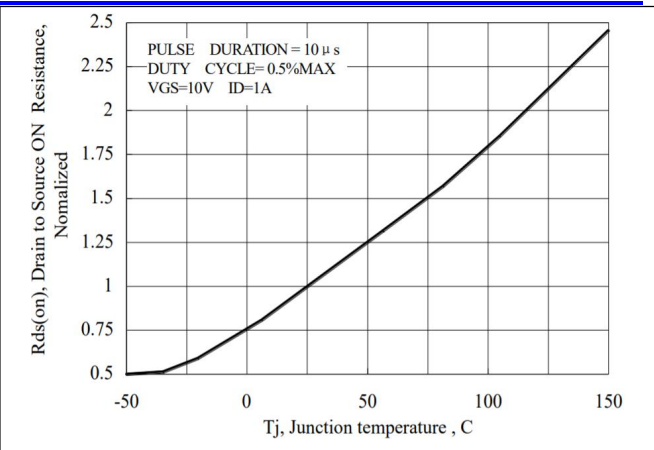
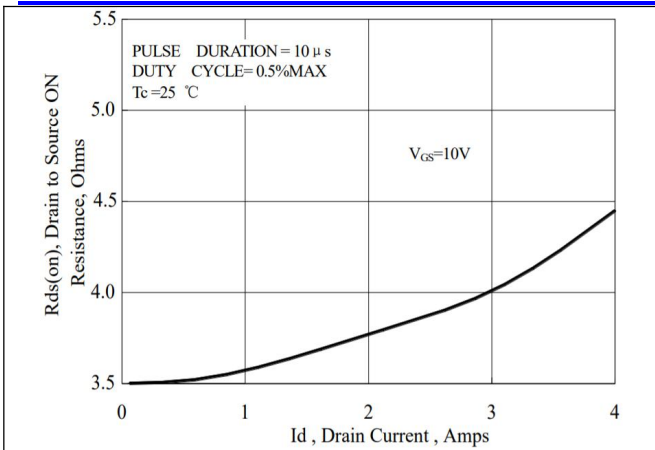
Maximum Effective Thermal Impedance, Junction to Case



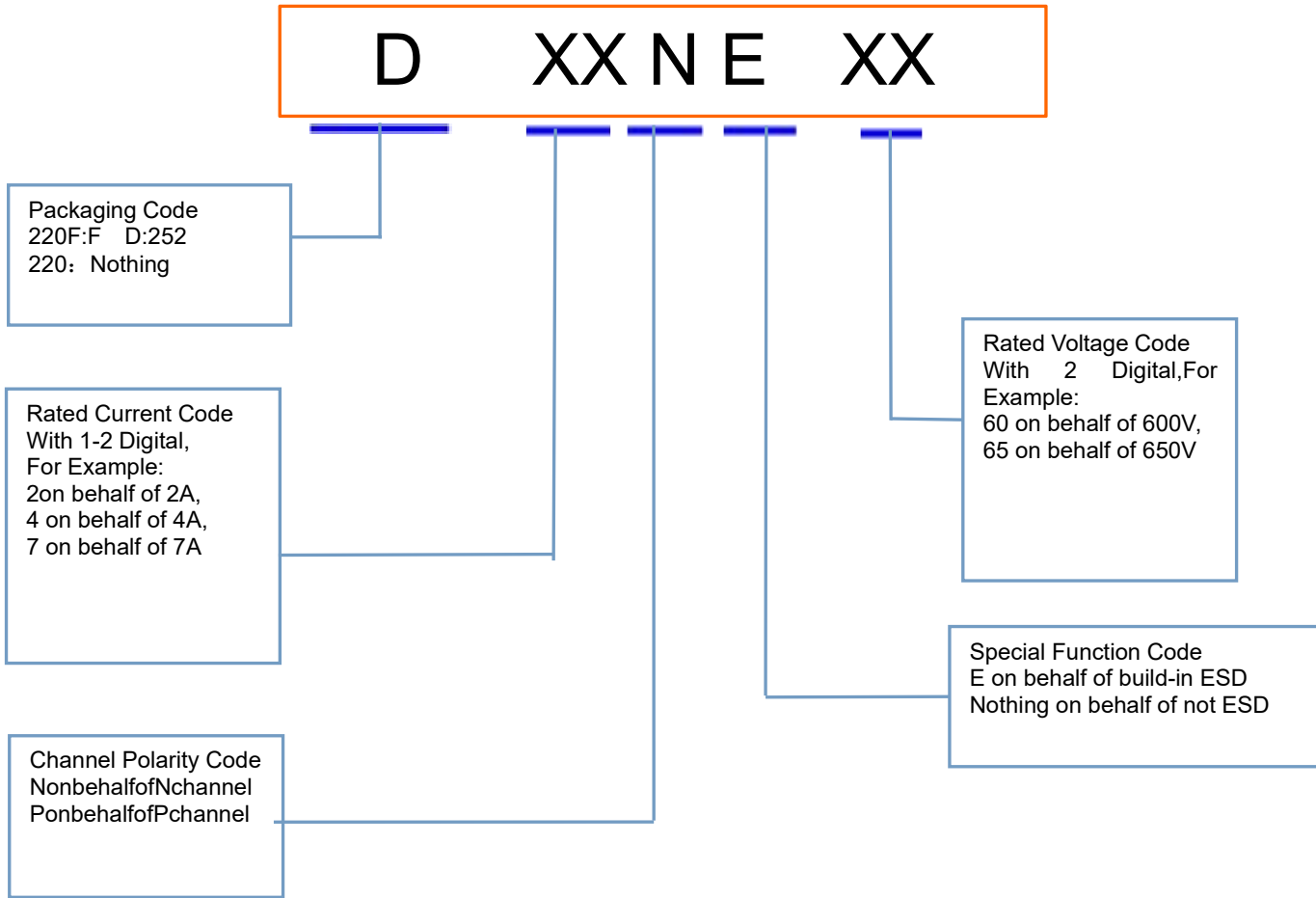
Typical Transfer Characteristics



Typical Body Diode Transfer Characteristics



## 7 Product Names Rules

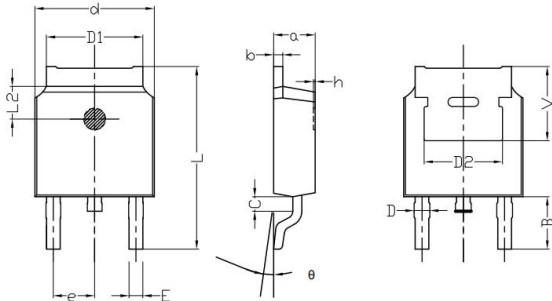


## 8 Product Specifications and Packaging Models

| Product Model | Package Type | Mark Name | RoHS    | Package | Quantity  |
|---------------|--------------|-----------|---------|---------|-----------|
| D2N60         | TO-252       | D2N60     | Pb-free | Braid   | 2500/disc |

## 9 Dimensions

### TO-252 PACKAGE OUTLINE DIMENSIONS



| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |        |
|--------|---------------------------|-------|----------------------|--------|
|        | min.                      | max.  | min.                 | max.   |
| a      | 2.20                      | 2.40  | 0.087                | 0.095  |
| b      | 0.46                      | 0.58  | 0.018                | 0.023  |
| c      | 0.70                      | 0.90  | 0.028                | 0.035  |
| D      | 0.80                      | 0.90  | 0.032                | 0.035  |
| d      | 6.50                      | 6.70  | 0.2561               | 0.2640 |
| D1     | 5.10                      | 5.46  | 0.201                | 0.215  |
| D2     | 4.73                      | 4.93  | 0.1864               | 0.1942 |
| A      | 6.00                      | 6.20  | 0.2364               | 0.2443 |
| e      | 2.19                      | 2.39  | 0.0861               | 0.0940 |
| L      | 10.40                     | 11.00 | 0.4098               | 0.4334 |
| B      | 3.5                       | 3.7   | 0.1379               | 0.1458 |
| L2     | 1.5                       | 1.7   | 0.0591               | 0.0670 |
| θ      | 0                         | 8     | 0                    | 8      |
| h      | 0                         | 0.3   | 0                    | 0.0118 |
| V      | 5.25                      | 5.45  | 0.2069               | 0.2147 |
| E      | 0.6                       | 0.8   | 0.0236               | 0.0315 |

## 10 Attentions

- Jiangsu Donghai Semiconductor Technology Co., Ltd. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of WXDH products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

## 11 Appendix

Revision history:

| Date       | REV. | Description | Page |
|------------|------|-------------|------|
| 2020.03.09 | 1.0  | Original    |      |